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The effect of iron-particles on the electrical properties of n-GaSb semiconductor material

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Semiconductor material are characterized with the Schottky barrier diodes (SBDs) as a basic structure. The study was conducted in order to check the effect of iron particles on the electrical properties of Gallium antimonide (GaSb) semiconductor material. Gallium Antimonide (GaSb) was implanted with iron particles at various ion fluences ranging from 1.2×10^{15} to 1.2×10^{17} cm⁻² while keeping the ion energy at 90 keV. Aluminium (Al) Schottky barrier diodes (SBDs) were fabricated on Te-doped n-type Gallium Antimonide implanted with Fe+ at various fluences. Structural and electrical properties have been investigated using the Raman spectroscopy and I-V characterization. I-V measurements were performed for all the samples. Raman spectroscopy shows a slight amorphization at fluences higher than 1.2×10^{15} cm⁻². The ideality factor (n) increased from 1.3 for the undoped to 2.0 for 1.2×10^{17} cm⁻². Generally, the barrier height decreased with the increasing doping fluences while the ideality factor increased with the increasing doping fluences.

Apply to be
 considered for a student
> award (Yes / No)?

Yes

Level for award
 (Hons, MSc,
 PhD, N/A)?

MSc

Primary author: Mr BELE, ABONGILE (Sefako Makgatho Health Sciences University)
Co-author: Prof. SITHOLE, Mpho Enoch (Sefako Makgatho Health Sciences University)
Presenter: Mr BELE, ABONGILE (Sefako Makgatho Health Sciences University)
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